

Notice of References Cited

Application/Control No.

10/750,351

Applicant(s)/Patent Under
Reexamination
DAVIES ET AL.

Examiner

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Art Unit

2162

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,802,528 A	09-1998	Oki et al.	707/201
*	B	US-2002/0199024 A1	12-2002	Givoly et al.	709/248
*	C	US-6,598,119 B2	07-2003	Becker et al.	711/119
*	D	US-2003/0158868 A1	08-2003	Zoltan, William	707/201
*	E	US-2004/0267729 A1	12-2004	Swaminathan et al.	707/003
*	F	US-2007/0016616 A1	01-2007	Brill et al.	707/104.1
*	G	US-7,222,139 B2	05-2007	Mau, Louis S.	707/204
*	H	US-2007/0143358 A1	06-2007	SASAKI et al.	707/201
*	I	US-2004/0158562	08-2004	Caulfield et al.	707/005
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	X				

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